## Application/Control No. Applicant(s)/Patent Under Reexamination 10/718,320 CHAO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1765 DuyVu n. Deo **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY Tsai et al. 430/313 US-5,753,418 05-1998 Α US-В US-С US-D US-Е US-F US-G USн US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т

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